

ENSC Batch No. \_\_\_\_\_ Wafers Started \_\_\_\_\_ Date \_\_\_\_\_  
 Material \_\_\_\_\_ Orientation \_\_\_\_\_ Size \_\_\_\_\_ Thickness \_\_\_\_\_  
 Resistivity \_\_\_\_\_ Type \_\_\_\_\_  
 Wafer Vendor \_\_\_\_\_ Vendor Batch # \_\_\_\_\_ SFU P.O. \_\_\_\_\_

Process Step #	Process Conditions	Oper & Wafer #	Comments
_____A	<b>Photoresist Strip</b> Soak wafer in room temp acetone for 5minutes. Rinse in fresh acetone 2 minutes. Inspect for completion at step D.		
_____B	<b>DI Water Rinse</b> > 3 minutes in running DI water		
_____C	<b>Dry</b> Spin at max RPM until dry (false colours disappear). Check for water on back. Repeat and/or blow dry with dry N2 if needed.		Alternate: blow dry with N2 and soft bake.
_____D	<b>Inspection</b> Microscope. Check for remnant resist.		Remnant resist may appear as films or as hair like structures.
_____E	<b>Prebake</b> Temp = 100C. Time = 10-30 min Cool before spinning photoresist		
_____F	<b>Spin Primer, Back Side (Optional)</b> Shipley Microposit. Flood surface. 4000 RPM. 30 seconds.  Be sure chuck is clean, to avoid contaminating the front of the wafer.		<u>Optional Steps, Back Side Processing:</u> Back side processing, consisting of steps F (optional), G and H, is normally performed only for micromachining applications where the back side of the wafer is to be processed or protected. <u>Optional Step:</u> HMDS (hexamethyldisilizane) is an adhesion promoter. Normally used only on wafers that have already been processed in EDP. Occasionally used on other wafers if unresolved resist adhesion problems encountered.
_____G	<b>Spin photoresist, Back Side (Optional)</b> Shipley SPR2. Flood surface. 4000 RPM. 30 seconds As above, chuck must be clean.		<u>Optional Step, Back Side Processing</u>
_____H	<b>Soft Bake, Back Side (Optional)</b> Temp = 100C. Time =5 min		<u>Optional Step, Back Side Processing</u>

_____I	<b>Spin Primer, Front Side (Optional)</b> Shipley Microposit. Flood surface. 4000 RPM. 30 seconds.		<u>Optional Step:</u> As in Step F, primer is used only if required. Be careful not to scratch coating on back side, if present.
_____J	<b>Spin photoresist, Front Side</b> Shipley SPR2. Flood surface. 4000 RPM. 30 seconds		Be careful not to scratch resist on back side, if present.
_____K	<b>Soft Bake</b> Temp = 100C. Time = 20 min		
_____L	<b>Inspect</b> Microscope with yellow light		Look for obvious resist faults.
_____M	<b>Exposure Tests</b> If correct exposure not known.		Exposure varies with surface and mask type. An Al surface might require 8 seconds with a chrome mask and about 15 seconds with an emulsion mask. An oxide surface might require about 30 seconds with an emulsion mask.
_____N	<b>Align and Expose</b> Use test results or experience.		
_____O	<b>Develop</b> MF319, undiluted. Room temp. Slight agitation. Develop until no more resist is being removed. Typical time about 60 seconds.		
_____P	<b>Rinse</b> Running DI H2O for > 3 min		
_____Q	<b>Dry</b> Do not spin dry. Resist contaminates chuck. Blow dry with N2, and bake in soft bake oven briefly if necessary.		
_____R	<b>Inspect</b> Microscope with yellow light. Look for complete development. Be sure there is no damage.		
_____S	<b>Hard Bake</b> Temp = 120C. Time = 20 min		Excessive hard bake can compromise resist strip. Too little hard bake can reduce resistance to etchants.